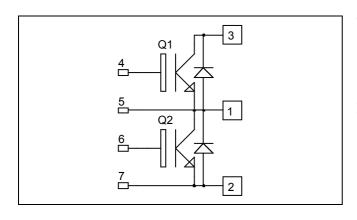
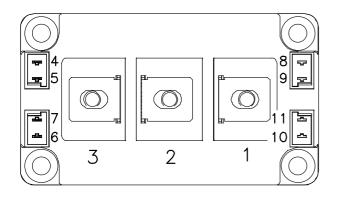


Phase leg Trench + Field Stop IGBT3 Power Module





# APTGT200A170D3G

# $V_{CES} = 1700V$ $I_{C} = 200A$ @ Tc = 80°C

### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### Features

- Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
- High level of integration
- M6 power connectors

#### Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive T<sub>C</sub> of V<sub>CEsat</sub>
- RoHS Compliant

### Absolute maximum ratings

Symbo	l Parameter		Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1700	V
т	Continuous Collector Current	$T_C = 25^{\circ}C$	310	
I <sub>C</sub>	Continuous Conector Current	$T_C = 80^{\circ}C$	200	А
I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	400	
V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
PD	Maximum Power Dissipation	$T_C = 25^{\circ}C$	1250	W
RBSO	A Reverse Bias Safe Operating Area	$T_j = 125^{\circ}C$	400A@1650V	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



# All ratings @ $T_j = 25^{\circ}C$ unless otherwise specified

Electrical Characteristics								
Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1700V$				3	mA	
V <sub>CE(on)</sub>	Collector Emitter on Voltage	$V_{GE} = 15V$	$T_j = 25^{\circ}C$		2.0	2.5	V	
V CE(on)	Conector Emitter on Voltage	$I_{\rm C} = 200 {\rm A}$ $T_{\rm j} = 125^{\circ} {\rm C}$		2.4		v		
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}$ , $I_C = 8 \text{ mA}$		5.2	5.8	6.4	V	
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA	

### **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V, V_{CE} = 25V$			18		nF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1 MHz			0.6		III.
Q <sub>G</sub>	Gate charge	V <sub>GE</sub> =±15V, I <sub>C</sub> =200A V <sub>CE</sub> =900V			2.3		μC
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switch	ning (25°C)		280		
Tr	Rise Time	$V_{GE} = \pm 15V$			80		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 900V$ $I_{C} = 200A$			850		ns
$T_{\rm f}$	Fall Time	$R_G = 6.8\Omega$		120			
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C) $V_{GE} = \pm 15V$ $V_{Bus} = 900V$ $I_C = 200A$ $R_G = 6.8\Omega$			300		ns
Tr	Rise Time				100		
T <sub>d(off)</sub>	Turn-off Delay Time				1000		
T <sub>f</sub>	Fall Time				200		
Б	Turn On Energy	$V_{GE} = \pm 15V$	$T_i = 25^{\circ}C$		58		
Eon	Turn On Energy	$V_{Bus} = 900V$	$T_{i} = 125^{\circ}C$		78		mJ
E <sub>off</sub>	Turn Off Energy	$I_{\rm C} = 200 {\rm A}$	$T_j = 25^{\circ}C$		43		1113
Loff	Turn Off Energy	$R_G = 6.8\Omega$	$_{\rm G} = 6.8\Omega$ $T_{\rm j} = 125^{\circ}{\rm C}$		63		
I <sub>sc</sub>	Short Circuit data	$V_{GE} \le 15V$ ; $V_{Bus} = 1000V$ $t_p \le 10\mu s$ ; $T_1 = 125^{\circ}C$			800		А

## Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1700			V
I <sub>RRM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1700V	$T_j = 25^{\circ}C$			750	μA
*KKM			$T_{j} = 125^{\circ}C$			1000	μ
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		200		А
V <sub>F</sub>	Diode Forward Voltage	$I_{\rm F} = 200 {\rm A}$	$T_j = 25^{\circ}C$		1.8	2.2	v
▼ F		1 <sub>F</sub> 20071	$T_i = 125^{\circ}C$		1.9		*
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 200A$ $V_R = 900V$ $di/dt = 3200A/\mu s$	$T_j = 25^{\circ}C$		385		ns
۲r			$T_{j} = 125^{\circ}C$		490		115
Q <sub>rr</sub>	Reverse Recovery Charge		$T_j = 25^{\circ}C$		56		μC
Qrr	Reverse Recovery Charge		$T_{j} = 125^{\circ}C$		92		μ
E <sub>rr</sub>	Reverse Recovery Energy		$T_j = 25^{\circ}C$		24		mJ
Lrr			$T_{j} = 125^{\circ}C$		48		1115

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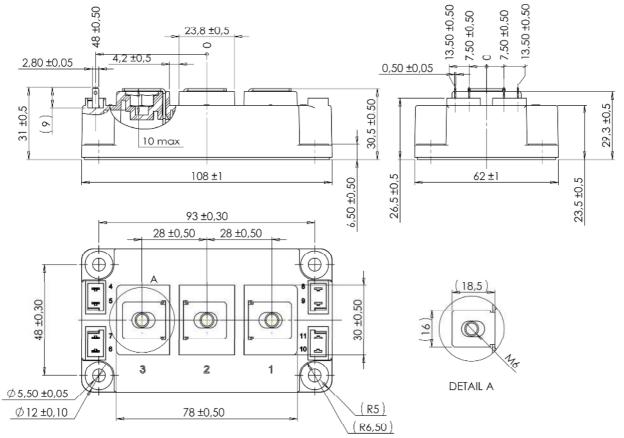


# APTGT200A170D3G

## Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
D	Junction to Case Thermal Resistance IGBT		IGBT			0.10	°C/W
R <sub>thJC</sub> Junction to Case Thermal Resistance Dio		Diode			0.16	C/ W	
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
T <sub>J</sub>	Operating junction temperature range		-40		150		
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C
T <sub>C</sub>	Operating Case Temperature			-40		125	
Torque	Mounting torque	For terminals	M6	3		5	N.m
		To Heatsink	M6	3		5	19.111
Wt	Package Weight					350	g

### D3 Package outline (dimensions in mm)



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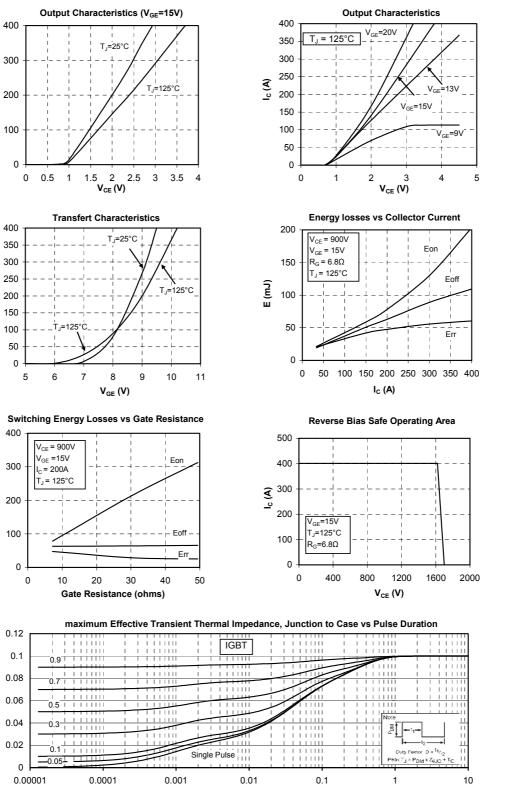
### **Typical Performance Curve**

I<sub>c</sub> (A)

I<sub>c</sub> (A)

E (mJ)

Thermal Impedance (°C/W)



# **APTGT200A170D3G**



<u>| | | | | |</u>

0.0001

0.001

0.1

-0.05

0.02

0

0.00001

# **APTGT200A170D3G**

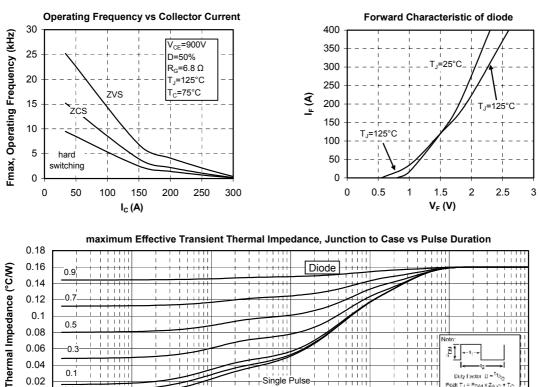
1

Duty Factor  $D = {}^{t_1}h_2$ Feak  $T_J = P_{DM} \times Z_{AJC} + T_C$ 

. . . . . .

. . . . .

0.1



Single Pulse

0.01

rectangular Pulse Duration (Seconds)

10



# APTGT200A170D3G

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